# IGBT with Monolithic Free Wheeling Diode

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Field Stop (FS) Trench construction, and provides superior performance in demanding switching applications, offering both low on–state voltage and minimal switching loss. The IGBT is well suited for resonant or soft switching applications.

#### Features

- Extremely Efficient Trench with Fieldstop Technology
- 1350 V Breakdown Voltage
- Optimized for Low Losses in IH Cooker Application
- Reliable and Cost Effective Single Die Solution
- These are Pb–Free Devices

#### **Typical Applications**

- Inductive Heating
- Consumer Appliances
- Soft Switching

#### ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CES</sub>	1350	V
Collector current @ Tc = 25°C @ Tc = 100°C	Ι <sub>C</sub>	40 20	A
Pulsed collector current, T <sub>pulse</sub> limited by T <sub>Jmax</sub> , 10 $\mu$ s Pulse, V <sub>GE</sub> = 15 V	I <sub>CM</sub>	120	A
Diode forward current @ Tc = 25°C @ Tc = 100°C	I <sub>F</sub>	40 20	A
Diode pulsed current, $T_{pulse}$ limited by $T_{Jmax}$ , 10 µs Pulse, $V_{GE}$ = 0 V	I <sub>FM</sub>	120	A
Gate-emitter voltage Transient Gate-emitter Voltage $(T_{pulse} = 5 \ \mu s, \ D < 0.10)$	V <sub>GE</sub>	±20 ±25	V
Power Dissipation @ Tc = 25°C @ Tc = 100°C	P <sub>D</sub>	394 197	W
Operating junction temperature range	ТJ	-40 to +175	°C
Storage temperature range	T <sub>stg</sub>	-55 to +175	°C
Lead temperature for soldering, 1/8" from case for 5 seconds	T <sub>SLD</sub>	260	°C

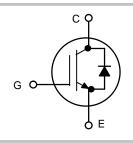
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

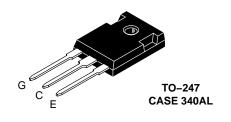


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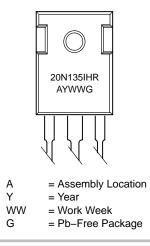
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20 A, 1350 V V<sub>CEsat</sub> = 2.20 V E<sub>off</sub> = 0.60 mJ





#### MARKING DIAGRAM



#### ORDERING INFORMATION

Device	Package	Shipping
NGTB20N135IHRWG	TO–247 (Pb–Free)	30 Units / Rail

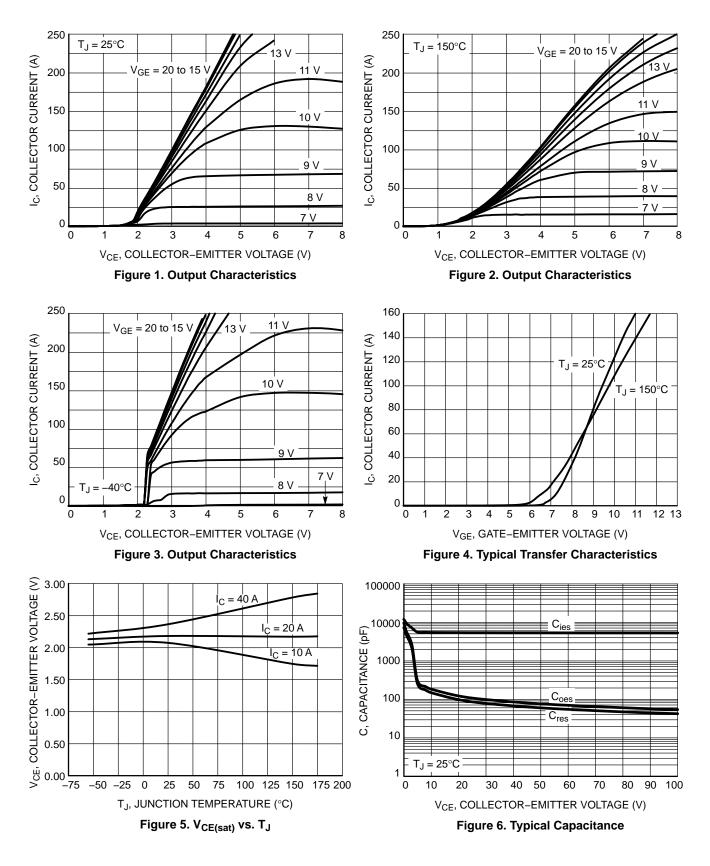
#### THERMAL CHARACTERISTICS

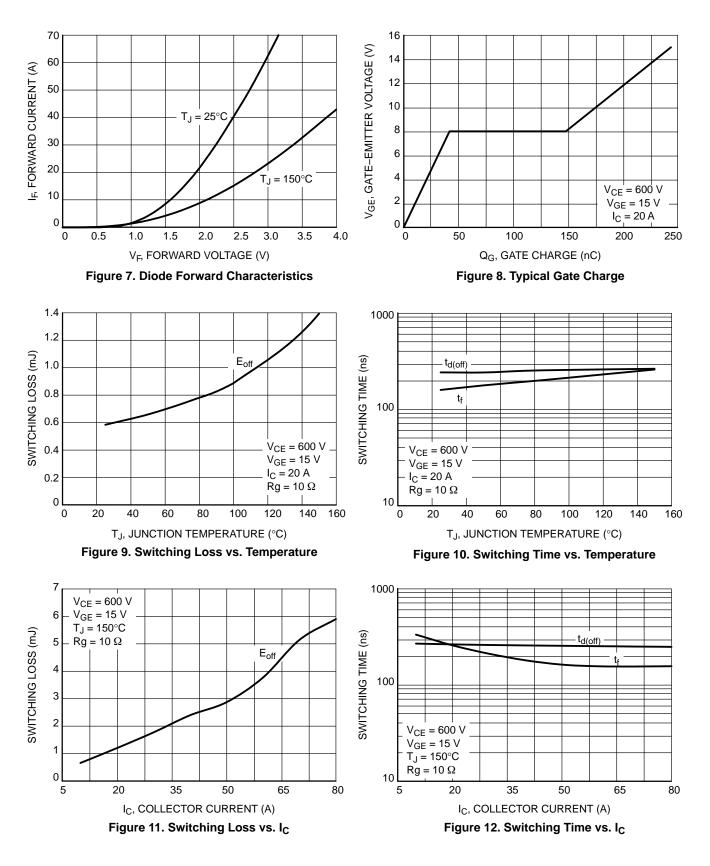
Rating	Symbol	Value	Unit
Thermal resistance junction-to-case	$R_{ extsf{ heta}JC}$	0.38	°C/W
Thermal resistance junction-to-ambient	$R_{ hetaJA}$	40	°C/W

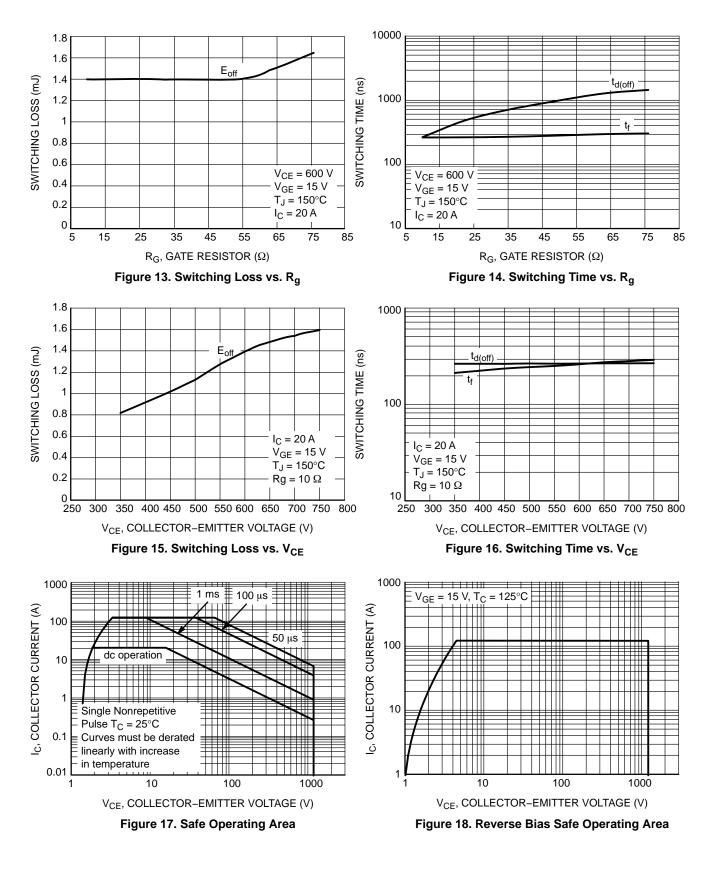
#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
STATIC CHARACTERISTIC	·			-		
Collector-emitter breakdown voltage, gate-emitter short-circuited	$V_{GE} = 0 \text{ V}, \text{ I}_{C} = 5 \text{ mA}$	V <sub>(BR)CES</sub>	1350	_	-	V
Collector-emitter saturation voltage	$V_{GE}$ = 15 V, I <sub>C</sub> = 20 A V <sub>GE</sub> = 15 V, I <sub>C</sub> = 20 A, T <sub>J</sub> = 175°C	V <sub>CEsat</sub>	-	2.20 2.40	2.65 -	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}, I_C = 250 \ \mu A$	V <sub>GE(th)</sub>	4.5	5.5	6.5	V
Collector-emitter cut-off current, gate- emitter short-circuited	$V_{GE} = 0 V, V_{CE} = 1350 V$ $V_{GE} = 0 V, V_{CE} = 1350 V, T_{J} = 175^{\circ}C$	I <sub>CES</sub>		_ _	0.5 2.0	mA
Gate leakage current, collector-emitter short-circuited	$V_{GE}$ = 20 V, $V_{CE}$ = 0 V	I <sub>GES</sub>	-	-	100	nA
DYNAMIC CHARACTERISTIC	·					
Input capacitance	V <sub>CE</sub> = 20 V, V <sub>GE</sub> = 0 V, f = 1 MHz	C <sub>ies</sub>	_	5290	_	pF
Output capacitance		C <sub>oes</sub>	-	124	-	
Reverse transfer capacitance		C <sub>res</sub>	-	100	-	
Gate charge total	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 20 A, V <sub>GE</sub> = 15 V	Qg	-	234	-	nC
Gate to emitter charge		Q <sub>ge</sub>	-	39	-	
Gate to collector charge		Q <sub>gc</sub>	-	105	-	
SWITCHING CHARACTERISTIC, INDUC	TIVE LOAD					
Turn-off delay time	$\begin{array}{c} {{\rm T_{J}}=25^{\circ}{\rm C}}\\ {{\rm V_{CC}}=600\;{\rm V,\;I_{C}}=20\;{\rm A}}\\ {{\rm R_{g}}=10\;{\Omega}}\\ {{\rm V_{GE}}=0\;{\rm V/\;15V}} \end{array}$	t <sub>d(off)</sub>	-	245	-	ns
Fall time		t <sub>f</sub>	-	175	-	
Turn-off switching loss		E <sub>off</sub>	-	0.60	-	mJ
Turn-off delay time	$T_J = 150$ °C V <sub>CC</sub> = 600 V, I <sub>C</sub> = 20 A R <sub>g</sub> = 10 Ω	t <sub>d(off)</sub>	-	270	-	ns
Fall time		t <sub>f</sub>	-	290	-	
Turn-off switching loss	V <sub>GE</sub> = 0 V/ 15V	E <sub>off</sub>	-	1.40	-	mJ
DIODE CHARACTERISTIC						
Forward voltage	V <sub>GE</sub> = 0 V, I <sub>F</sub> = 20 A V <sub>GE</sub> = 0 V, I <sub>F</sub> = 20 A, T <sub>J</sub> = 175°C	V <sub>F</sub>	-	1.80 2.70	2.10 -	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.







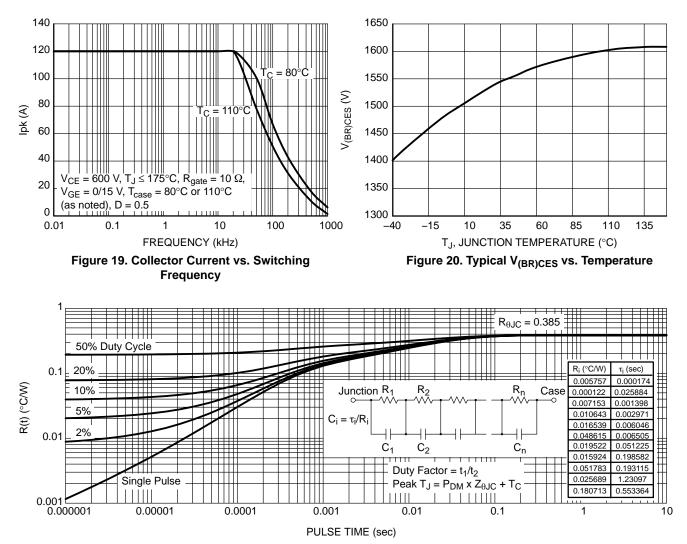


Figure 21. IGBT Transient Thermal Impedance

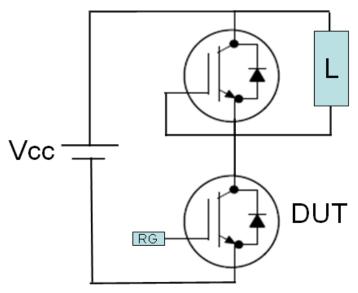
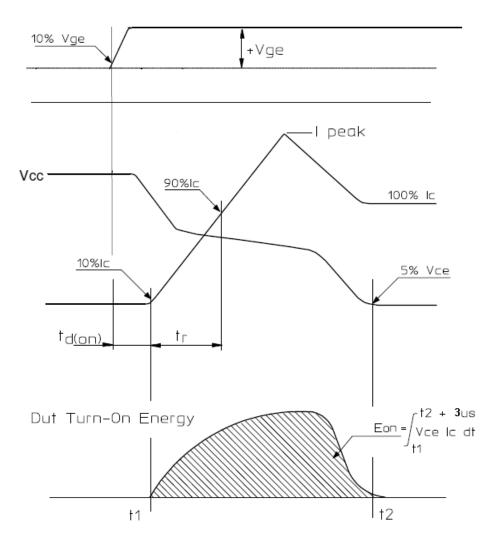
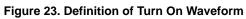
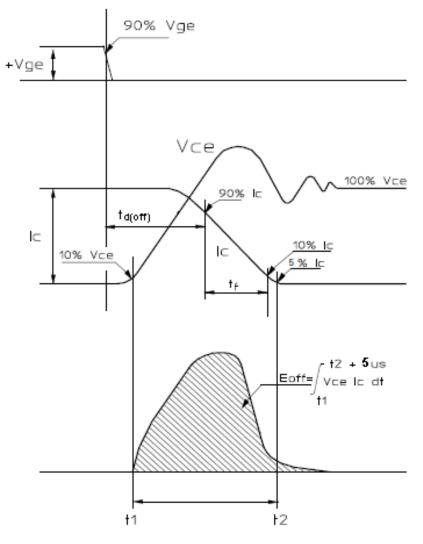
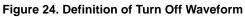


Figure 22. Test Circuit for Switching Characteristics



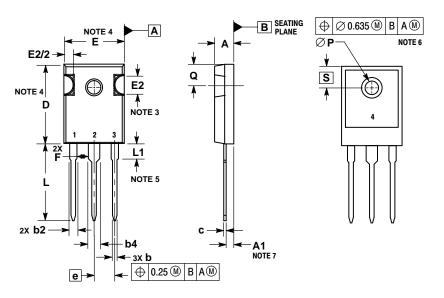






#### PACKAGE DIMENSIONS

TO-247 CASE 340AL ISSUE D



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  SLOT REQUIRED, NOTCH MAY BE ROUNDED
- SLOT REQUIRED, NOTCH MAY BE ROUNDED.
  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREME OF THE PLASTIC BODY.
- LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.
- OP SHALL HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM DIAMETER OF 3.91.
- TOP OF THE PART WITH A MAXIMUM DIAMETER OF 3.91. 7. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED

BY L1.			
	MILLIMETERS		
DIM	MIN	MAX	
Α	4.70	5.30	
A1	2.20	2.60	
b	1.07	1.33	
b2	1.65	2.35	
b4	2.60	3.40	
C	0.45	0.68	
D	20.80	21.34	
Ε	15.50	16.25	
E2	4.32	5.49	
е	5.45 BSC		
F	2.655		
L	19.80	20.80	
L1	3.81	4.32	
Р	3.55	3.65	
Q	5.40	6.20	
S	6.15 BSC		

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